

FCC - TEST REPORT

Report Number	:	60.790.18.051.01R01	Date of Issue	: _	January 15, 2019
Model	:	Door Lock, Glass Lock	, Plunger Lock		
Product Type	:	Digital Lock			
Applicant	:	Mobile Technologies Inc			
Address	:	1050 NE 67th Ave, Hillst	ooro, OR 97124		
Production Facility	:	PS Gmbh			
Address	:	Melisau 1255, Autria, 68	63 Egg.		
Test Result	:	■Positive	□Negative		
Total pages including Appendices	:	17			

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2 Description of Equipment Under Test

Description of the Equipment Under Test

Product: Digital Lock

Model no.: Door Lock, Glass Lock, Plunger Lock

FCC ID: 2AA2X-1500011824

Rating: 3V DC (CR 123A battery)

Frequency: 125kHz (Tx and Rx)

Modulation: AM



3 Summary of Test Standards

Test Standards

FCC Part 15 Subpart C 10-1-17 Edition
Federal Communications Commission, PART 15 — Radio Frequency Devices,
Subpart C — Unintentional Radiators

All the tests were performed using the procedures from ANSI C63.4(2014) and ANSI C63.10 (2013).



4 Details about the Test Laboratory

Site 1

Company name: TÜV SÜD Hong Kong Ltd.

3/F, West Wing, Lakeside 2, 10 Science Park West Avenue, Science Park, Shatin, Hong Kong

Site 2

Company name: TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch

Building 12&13 Zhiheng Wisdomland Business Park,

Nantou Checkpoint Road 2, Shenzhen 518052, P.R.China FCC Registration Number: 514049

Emission Tests			
Test Item	Test Site		
FCC Part 15 Subpart C			
FCC Title 47 Part 15.205, 15.209 Spurious Radiated Emission	Site 2		
FCC Title 47 Part 15.207 Conduct Emission	NA		
FCC Title 47 Part 15.215 20dB Bandwidth	Site 2		



4.1 Test Equipment Site List

Radiated emission Test - Site 2

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
EMI Test Receiver	Rohde & Schwarz	ESR 26	101269	2019-7-6
Loop Antenna	Rohde & Schwarz	HFH2-Z2	100398	2019-7-6
Trilog Super Broadband Test Antenna	Schwarzbeck	VULB 9163	707	2019-6-28
Horn Antenna	Rohde & Schwarz	HF907	102294	2019-6-28
Pre-amplifier	Rohde & Schwarz	SCU 18	102230	2019-7-6
Signal Generator	Rohde & Schwarz	SMY01	839369/005	2019-7-6
Attenuator	Agilent	8491A	MY39264334	2019-7-6
3m Semi-anechoic chamber	TDK	9X6X6		2020-7-7
Test software	Rohde & Schwarz	EMC32	Version 9.15.00	N/A

Conducted Emission Test - Site 2

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
EMI Test Receiver	Rohde & Schwarz	ESR 3	101782	2019-7-6
LISN	Rohde & Schwarz	ENV4200	100249	2019-7-6
LISN	Rohde & Schwarz	ENV432	101318	2019-7-6
LISN	Rohde & Schwarz	ENV216	100326	2019-7-6
ISN	Rohde & Schwarz	ENY81	100177	2019-7-6
ISN	Rohde & Schwarz	ENY81-CA6	101664	2019-7-6
High Voltage Probe	Rohde & Schwarz	TK9420(VT94 20)	9420-584	2019-6-30
RF Current Probe	Rohde & Schwarz	EZ-17	100816	2019-6-30
Attenuator	Shanghai Huaxiang	TS2-26-3	080928189	2019-7-6
Test software	Rohde & Schwarz	EMC32	Version9.15.00	N/A

20dB Bandwidth- Site 2

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
Signal Analyzer	Rohde & Schwarz	FSV40	101030	2019-7-6



4.2 Measurement System Uncertainty

Measurement System Uncertainty Emissions

System Measurement Uncertainty				
Items	Extended Uncertainty			
Uncertainty for Radiated Emission in 3m chamber 9kHz-30MHz	4.46dB			
Uncertainty for Radiated Emission in 3m chamber 30MHz-1000MHz	Horizontal: 4.91dB; Vertical: 4.89dB;			
Uncertainty for Radiated Emission in 3m chamber 1000MHz-18000MHz	Horizontal: 4.80dB; Vertical: 4.79dB;			
Uncertainty for Conducted Emission at AC Power Line 150kHz-30MHz	3.21dB			
Uncertainty for frequency test	0.6×10-7			



5 Summary of Test Results

Emission Tests				
FCC Part 15 Subpart C				
Test Condition	Pages	Те	st Resi	ult
		Pass	Fail	N/A
FCC Title 47 Part 15.205, 15.209 Spurious Radiated Emission	12-14	\boxtimes		
FCC Title 47 Part 15.207 Conduct Emission (1)	NIL			\boxtimes
FCC Title 47 Part 15.215 20dB Bandwidth	16			

Remark:

⁽¹⁾ Conducted Emission testing is not applicable for battery operating device.



6 General Remarks

Remarks

Client informs that the **Glass Lock and Plunger Lock** have the same technical construction including circuit diagram and electrical construction, with **Digital Lock**, **Door Lock**. The difference lies only in the outlook/color, PCB Layout, components, component layout and mechanical construction of the different models. (Client's conformation letter shown at appendix A)

EMC tests were performed on all three models, only the Door Lock's data was shown on this report, which is the worst case.

This submittal(s) (test report) is intended for **FCC ID: 2AA2X-1500011824**, complies with Section 15.205, 15.207, 15.209, 15.215 of the FCC Part 15, Subpart C rules.

The TX and RX range is 125kHz.

SUMMARY:

- All tests according to the regulations cited on page 8 were
 - - Performed
 - □ Not Performed
- The Equipment Under Test
 - - **Fulfills** the general approval requirements.
 - □ **Does not** fulfill the general approval requirements.

Sample Received Date: October 10, 2018

Testing Start Date: October 16, 2018

Testing End Date: January 7, 2019

Reviewed by:

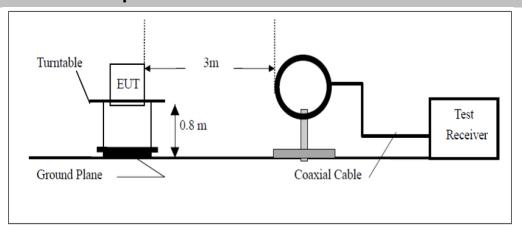
Hosea CHAN EMC Project Engineer Prepared by

Eric LI EMC Senior Project Engineer

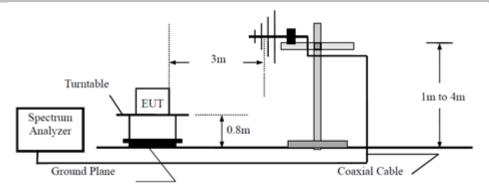


7 Test Setups

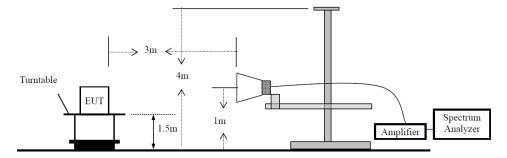
7.1 Radiated test setups 9kHz-30MHz



7.2 Radiated test setups Below 1GHz

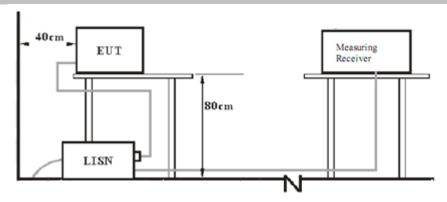


7.3 Radiated test setups Above 1GHz

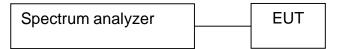




7.4 AC Power Line Conducted Emission test setups



7.5 Conducted RF test setups





8 Emission Test Results

8.1 Spurious Radiated Emission

EUT: Door Lock

Op Condition: Operated, TX Mode Test Specification: FCC15.205, 15.209

Comment: 3V DC

Remark: 9kHz to 30MHz

Test Result
□ Passed
Not Passed

Frequency	Result	Limit	Margin	Detector
MHz	dBµV/m	dBµV/m	dB	PK/QP/AV
0.125	49.52	105.67	-56.15	Peak
0.250	48.23	99.65	-51.42	Peak
0.468	51.23	94.20	-42.97	Peak



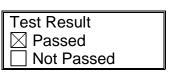
Spurious Radiated Emission

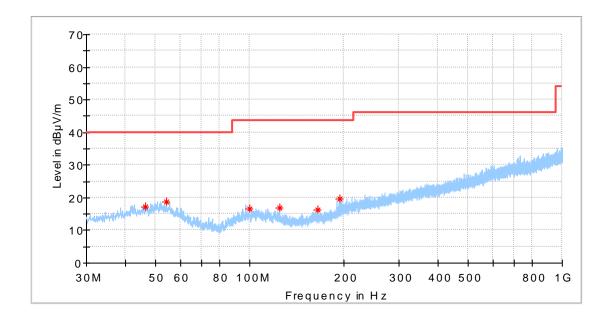
EUT: Door Lock

Op Condition: Operated, TX Mode Test Specification: FCC15.205, 15.209

Comment: 3V DC

Remark: 30MHz to 1GHz, Antenna: Horizontal





Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)
46.247500	17.30	40.00	-22.70
54.250000	18.81	40.00	-21.19
99.597500	16.49	43.50	-27.01
124.271875	16.78	43.50	-26.72
164.587500	16.21	43.50	-27.29
193.748125	19.66	43.50	-23.84



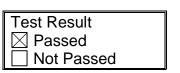
Spurious Radiated Emission

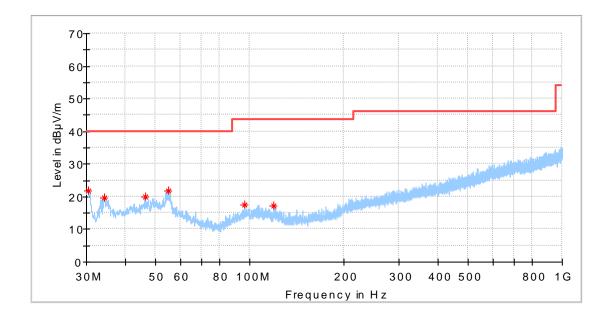
EUT: Door Lock

Op Condition: Operated, TX Mode Test Specification: FCC15.205, 15.209

Comment: 3V DC

Remark: 30MHz to 1GHz, Antenna: Vertical





Frequency (MHz)	MaxPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)
30.424375	21.71	40.00	-18.29
34.365000	19.62	40.00	-20.38
46.247500	19.82	40.00	-20.18
55.098750	21.67	40.00	-18.33
96.141875	17.50	43.50	-26.00
118.936875	17.18	43.50	-26.32



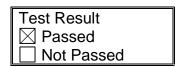
8.2 6dB & 99% Bandwidth

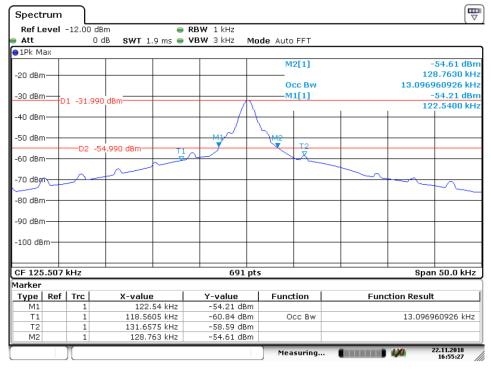
EUT: Door Lock

Op Condition: Operated, TX Mode

Test Specification: FCC15.215, 20dB Bandwidth

Comment: 3V DC





Date: 22.NOV.2018 16:55:27

Bandwidth	Measured Value
20dB bandwidth	6.2 kHz
99% bandwidth	13.1 kHz



9 Appendix A General Product Information

Radiofrequency radiation exposure evaluation

According to KDB 447498 D01v06 section 4.3.1, For frequencies below 100 MHz and test separation distances ≤ 50 mm, the Numeric threshold is determined as:

Step a)

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] · [√f(GHz)] ≤ 3.0 for 1-g SAR

Step b)

{[Power allowed at numeric threshold for 50mm in step a)] + [(test separation distance – 50mm) · (f(MHz)/150)]} mW

Step c) 1

For test separation distances > 50mm and < 200mm, the power threshold at the corresponding test separation distance at 100MHz in step b) is multiplied by [1 + log(100/f(MHz))]

Step c) 2

For test separation distances \leq 50mm, the power threshold determined by the equation in c) 1) for 50mm and 100MHz is multiplied by $\frac{1}{2}$.

>> The fundamental frequency of the EUT is 125kHz, the test separation distance is ≤ 50mm. (Manufacturer specified the separation distance is: 20mm)

Step a)

>> Numeric threshold, mW / 50mm * √0.1GHz ≤ 3.0 Numeric threshold ≤ 474.3mW

Step b)

>> Numeric threshold ≤ 474.3mW + (50mm-50mm * 100MHz/150) Numeric threshold ≤ 474.3mW

Step c) 1) & c) 2)

>> Numeric threshold ≤ 474.3mW * [1 + log 100/100MHz] * ½ Numeric threshold ≤ 237.15mW

>> The transmitter strength of EUT measured is: 49.52 dBµV/m

The power calculated is 0.000001786487mW

Which is smaller than the Numeric threshold.

Therefore, the device is exempt from stand-alone SAR test requirements.



General Product Information

Declaration letter of model difference



To:

TÜV SÜD Hong Kong Limited

Attention:

Mr. Edmond Fung

From:

Audy Tse

Date: Janua

January 21, 2019

Fax No:

Total Page (Cover Included):

Project No.:

Subject:

Declaration letter

We: Mobile Technologies Inc.

Officially notify TÜV SÜV Hong Kong Limited that the Door Lock and Plunger Lock have the same technical construction including circuit diagram and electrical construction, with Digital Lock, Glass Lock. The difference lies only in the outlook/color, PCB Layout, components, component layout and mechanical construction of the different models.

Model A: Door Lock

Model B: Plunger Lock

Model C: Glass Lock

Product: Digital Lock

Applicant:

Jan 21.2019

(Date)

Solution of the state of the st

(Applicant's authorized signature and company Chop)